

BRIGHT LED ELECTRONICS CORP.

LED DISPLAY SPECIFICATION

TOTAL PAGE: 4

PAGE: 1 VERSION: 1.0

● COMMODITY: .40"(10.16mm) DUAL DIGIT LED DISPLAY

● DEVICE NUMBER: BD-A406ND

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DATE								
2003.06.26	1.0	1.0	1.0	1.0				Original Release

TOTAL PAGE 4

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BRIGHT LED ELECTRONICS CORP.

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APPROVED	DRAWER
第 2003.07.01 榮光	余 2003.07.01 芳 芳

BRIGHT LED ELECTRONICS CORP.

LED DISPLAY SPECIFICATION

COMMODITY: 0.40"(10.16mm) DUAL DIGIT LED DISPLAY

PAGE: 2

●DEVICE NUMBER: BD-A406ND

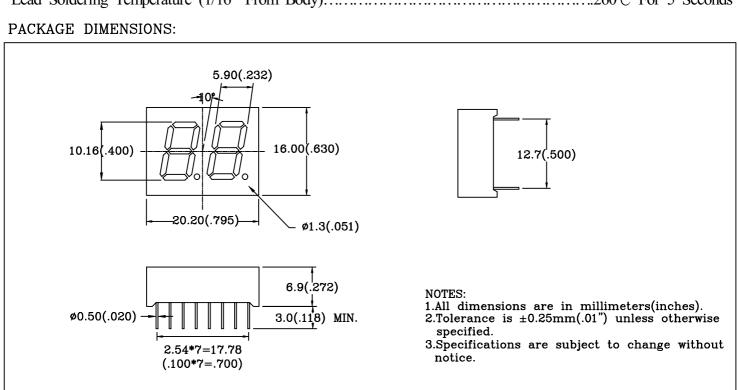
VERSION: 1.0

●ELECTRICAL AND OPTICAL CHARACTERISTICS (Ta=25°C)

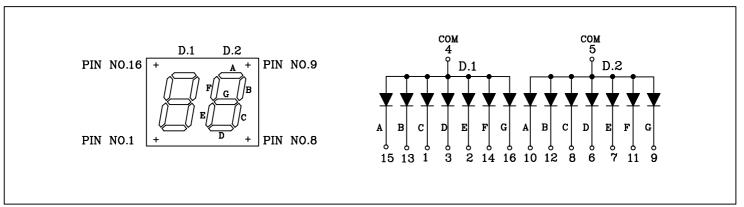
Chip	Absolute Maximum				Electro-optical					
Peak		Rating				Data (At 10mA)			Surface	Segment
Emitted Wave Color Length	Wave Length	A 2		If	Peak	Vf(V)		Iv Typ.	Color	Color
	$\lambda_{P}(nm)$	(nm)	(mW)	(mA)	If(mA)	Тур.	Max.	(mcd)		
Super Red	660	20	80	30	150	1.7	2.5	6.5	Black	White

lacktriangle ABSOLUTE MAXIMUM RATINGS (Ta=25°C)

Reverse Voltage		5V
Reverse Current (V _R =5V)		
Operating Temperature Range		
Storage Temperature Range	-40°C	~ 85°C
Lead Soldering Temperature (1/16" From Body)	For 5	Seconds



PIN FUNCTIONS:



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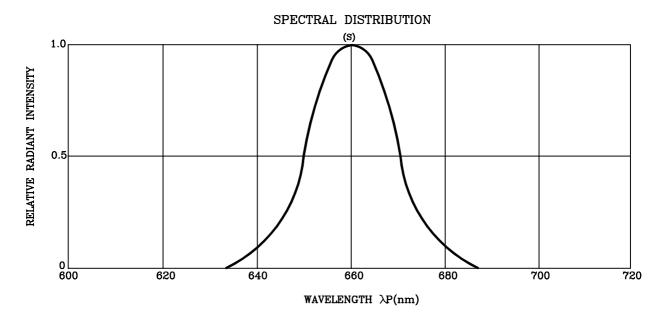
TYPICAL CHARACTERISTICS

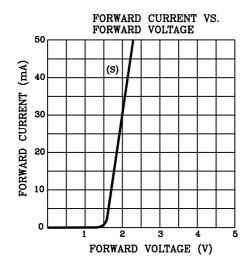
PAGE:

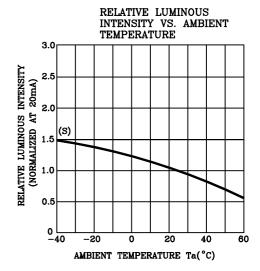
3

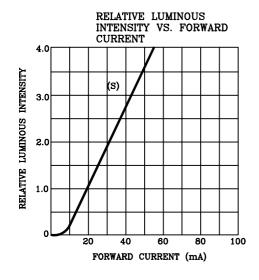
DEVICE NUMBER:BD-A406ND

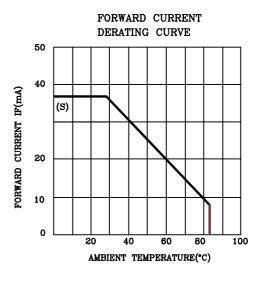
VERSION:1.0











RELIABILITY TEST

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DEVICE NO.: BD-A406ND

Classification	Test Item	Reference Standard	Test Conditions	Result
	Operation Life	MIL-STD-750:1026 MIL-STD-883:1005 JIS C 7021 :B-1	Connect with a power If=30mA Ta=Under room temperature Test time=1,000hrs(-24hrs,+72hrs)	0/10
Endurance Test	High Temperature High Humidity Storage	MIL-STD-202:103B JIS C 7021 :B-11	Ta=65°C ±5°C RH=90%-95% Test time=240hrs±2hrs	0/10
	High Temperature Storage	MIL-STD-883:1008 JIS C 7021 :B-10	High Ta=85°C ±5°C Test time=1,000hrs(-24hrs,+72hrs)	0/10
	Low Temperature Storage	JIS-C-7021 :B-12	Low Ta= -35°C ±5°C Test time=1,000hrs(-24hrs,+72hrs)	0/10
	Temperature Cycling	MIL-STD-202:107D MIL-STD-750:1051 MIL-STD-883:1010 JIS C 7021 :A-4	-35°C ~25°C ~85°C ~25°C 30min 5min 30min 5min Test Time=10cycle	0/10
Environmental Test	Thermal Shock	MIL-STD-202:107D MIL-STD-750:1051 MIL-STD-883:1011	85° C $\pm 5^{\circ}$ C $\sim -35^{\circ}$ C $\pm 5^{\circ}$ C 10min 10 min Test Time= 10 cycle	0/10
	Solder Resistance	MIL-STD-202:201A MIL-STD-750:2031 JIS C 7021 :A-1	T.sol= 260 ± 5 °C Dwell Time= 10 ± 1 sec.	0/10
	Solderability	MIL-STD-202:208D MIL-STD-750:2026 MIL-STD-883:2003 JIS C 7021 :A-2	T.sol=230 ± 5 °C Dwell Time=5 ± 1 sec.	0/10

JUDGMENT CRITERIA OF FAILURE FOR THE RELIABILITY

Measuring items	Symbol	Measuring conditions	Judgement criteria for failure
Forward voltage	VF	IF=10mA	Over Ux1.2
Reverse current	IR	VR=5V	Over Ux2
Luminous intensity	IV	IF=10mA	Below Sx0.5

Note: 1.U means the upper limit of specified characteristics. S means initial value.

2.Measurment shall be taken between 2 hours and after the test pieces have been returned to normal ambient conditions after completion of each test.